# onsemi

MARKING DIAGRAMS

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### **1-Bit 100 Mb/s Configurable Dual-Supply Level Translator**

## **NLSX5011**

The NLSX5011 is a 1-bit configurable dual-supply autosensing bidirectional level translator that does not require a direction control pin. The I/O V<sub>CC</sub>- and I/O V<sub>L</sub>-ports are designed to track two different power supply rails, V<sub>CC</sub> and V<sub>L</sub> respectively. Both the V<sub>CC</sub> and the V<sub>L</sub> supply rails are configurable from 0.9 V to 4.5 V. This allows a logic signal on the V<sub>L</sub> side to be translated to either a higher or a lower logic signal voltage on the V<sub>CC</sub> side, and vice-versa.

The NLSX5011 offers the feature that the values of the  $V_{CC}$  and  $V_L$  supplies are independent. Design flexibility is maximized because  $V_L$  can be set to a value either greater than or less than the  $V_{CC}$  supply. In contrast, the majority of competitive auto sense translators have a restriction that the value of the  $V_L$  supply must be equal to less than  $(V_{CC} - 0.4)$  V.

The NLSX5011 has high output current capability, which allows the translator to drive high capacitive loads such as most high frequency EMI filters. Another feature of the NLSX5011 is that each  $I/O_V_{Ln}$  and  $I/O_V_{CCn}$  channel can function as either an input or an output.

An Output Enable (EN) input is available to reduce the power consumption. The EN pin can be used to disable both I/O ports by putting them in 3-state which significantly reduces the supply current from both  $V_{CC}$  and  $V_L$ . The EN signal is referenced to the  $V_L$  supply.

#### Features

- Wide V<sub>CC</sub>, V<sub>L</sub> Operating Range: 0.9 V to 4.5 V
- $V_L$  and  $V_{CC}$  are independent -  $V_L$  may be greater than, equal to, or less than  $V_{CC}$
- High 100 pF Capacitive Drive Capability
- High–Speed with 140 Mb/s Guaranteed Date Rate for V<sub>CC</sub>, V<sub>L</sub> > 1.8 V
- Low Bit-to-Bit Skew
- Overvoltage Tolerant Enable and I/O Pins
- Non-preferential Power-Up Sequencing
- Power-Off Protection
- Small UDFN6 Packaging
- These are Pb-Free Devices

#### **Typical Applications**

• Mobile Phones, PDAs, Other Portable Devices

#### Important Information

- ESD Protection for All Pins:
  - HBM (Human Body Model) > 8000 V



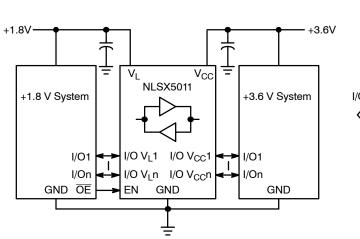


2, P, D = Specific Device Code M = Date Code

UDFN6, 1.2 x 1.0

MU SUFFIX CASE 517AA

#### ORDERING INFORMATION



**Figure 1. Typical Application Circuit** 

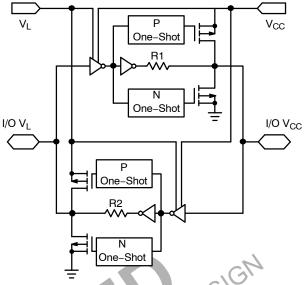
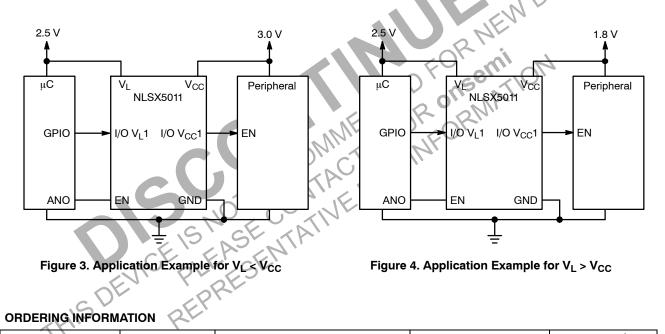


Figure 2. Simplified Functional Diagram (1 I/O Line)



### ORDERING INFORMATION

Device	Package	Marking	Pin 1 Orientation	Shipping <sup>†</sup>
NLSX5011AMUTAG	UDFN6.	D with 90 degree clockwise rotation	Pin 1 Toward Upper Left	
NLSX5011AMUTBG	1.45x1.0, 0.5P	2 with 270 degree clockwise rotation	Pin 1 Toward Upper Right	
NLSX5011AMUTCG	(Pb–Free)	D with 90 degree clockwise rotation	Pin 1 Toward Lower Left	3000 / Tape & Reel
NLSX5011MUTCG	UDFN6, 1.2x1.0, 0.4P (Pb–Free)	P with 90 degree clockwise rotation	Pin 1 Toward Lower Left	

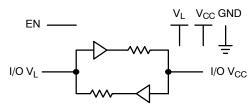


Figure 5. Logic Diagram

#### **PIN ASSIGNMENT**

Pins	Description
V <sub>CC</sub>	V <sub>CC</sub> Input Voltage
VL	V <sub>L</sub> Input Voltage
GND	Ground
EN	Output Enable
I/O V <sub>CC</sub> n	I/O Port, Referenced to V <sub>CC</sub>
I/O V <sub>L</sub> n	I/O Port, Referenced to VL

#### MAXIMUM BATINGS

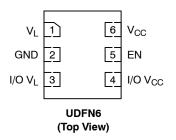


Figure 6. Pin Assignments

#### **FUNCTION TABLE**

EN	Operating Mode
L	Hi–Z
Н	I/O Buses Connected
	FSIGN

I/O Port, Referenced to V <sub>CC</sub>		DE	
I/O Port, Referenced to VL			
IM RATINGS		NE	
Parameter	Value	Condition	Unit
High-side DC Supply Voltage	-0.5 to +5.5		V
Low-side DC Supply Voltage	-0.5 to +5.5	2011	V
V <sub>CC</sub> -Referenced DC Input/Output Voltage	+0.5 to +5.5	· · · · · · · · · · · · · · · · · · ·	V
V <sub>L</sub> -Referenced DC Input/Output Voltage	-0.5 to +5.5		V
Enable Control Pin DC Input Voltage	-0,5 to +5.5		V
DC Input Diode Current	-50	V <sub>I</sub> < GND	mA
DC Output Diode Current	-50	V <sub>O</sub> < GND	mA
DC Supply Current Through V <sub>CC</sub>	±100		mA
DC Supply Current Through VL	±100		mA
DC Ground Current Through Ground Pin	±100		mA
Storage Temperature	–65 to +150		°C
	I/O Port, Referenced to V <sub>CC</sub> I/O Port, Referenced to V <sub>L</sub> I/O Port, Referenced to V <sub>L</sub> IM RATINGS         Parameter         High-side DC Supply Voltage         Low-side DC Supply Voltage         V <sub>CC</sub> -Referenced DC Input/Output Voltage         V <sub>L</sub> -Referenced DC Input/Output Voltage         Enable Control Pin DC Input Voltage         DC Input Diode Current         DC Output Diode Current         DC Supply Current Through V <sub>CC</sub> DC Ground Current Through Ground Pin	I/O Port, Referenced to $V_{CC}$ I/O Port, Referenced to $V_L$ I/O Port, Referenced to $V_L$ IM RATINGS         Parameter       Value         High-side DC Supply Voltage       -0.5 to +5.5         Low-side DC Supply Voltage       -0.5 to +5.5         V <sub>CC</sub> -Referenced DC Input/Output Voltage       -0.5 to +5.5         V <sub>L</sub> -Referenced DC Input/Output Voltage       -0.5 to +5.5         DC Input Diode Current       -50         DC Output Diode Current       -50         DC Supply Current Through $V_{CC}$ $\pm$ 100         DC Supply Current Through Ground Pin $\pm$ 100	I/O Port, Referenced to V <sub>CC</sub> I/O Port, Referenced to V <sub>L</sub> I/O Port, Referenced to V <sub>L</sub> MRATINGS         Parameter       Value       Condition         High-side DC Supply Voltage       -0.5 to +5.5       Condition         Low-side DC Supply Voltage       -0.5 to +5.5       Condition         V <sub>CC</sub> -Referenced DC Input/Output Voltage       -0.5 to +5.5       Condition         V <sub>L</sub> -Referenced DC Input/Output Voltage       -0.5 to +5.5       Condition         DC Input Diode Current       -50       V <sub>I</sub> < GND         DC Output Diode Current       -50       V <sub>Q</sub> < GND         DC Supply Current Through V <sub>L</sub> ± 100       Endle         DC Supply Current Through VL       ± 100       Endle

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### **RECOMMENDED OPERATING CONDITIONS**

Symbol	Parameter		Min	Мах	Unit
V <sub>CC</sub>	High-side Positive DC Supply Voltage	0.9	4.5	V	
VL	Low-side Positive DC Supply Voltage	0.9	4.5	V	
VI	Enable Control Pin Voltage		GND	4.5	V
V <sub>IO</sub>	Bus Input/Output Voltage	I/O V <sub>CC</sub> I/O V <sub>L</sub>	GND GND	4.5 4.5	V
T <sub>A</sub>	Operating Temperature Range		-55	+125	°C
Δt/ΔV	Input Transition Rise or Rate V <sub>I</sub> , V <sub>IO</sub> from 30% to 70% of V <sub>CC</sub> ; V <sub>CC</sub> = 3.3 V $\pm~$ 0.3 V		0	10	ns

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

#### DC ELECTRICAL CHARACTERISTICS

					-4	0°C to +85	5°C	–55°C to		
Symbol	Parameter	Test Conditions (Note 1)	V <sub>CC</sub> (V) (Note 2)	<b>V<sub>L</sub> (V)</b> (Note 3)	Min	<b>Typ</b> (Note 4)	Max	Min	Max	Unit
V <sub>IHC</sub>	I/O V <sub>CC</sub> Input HIGH Voltage		0.9-4.5	0.9-4.5	2/3 * V <sub>CC</sub>	-	-	2/3 * V <sub>CC</sub>	-	V
V <sub>ILC</sub>	I/O V <sub>CC</sub> Input LOW Voltage		0.9-4.5	0.9-4.5	-	_	1/3 * V <sub>CC</sub>	-	1/3 * V <sub>CC</sub>	V
V <sub>IHL</sub>	I/O V <sub>L</sub> Input HIGH Voltage		0.9-4.5	0.9-4.5	2/3 * VL	_	-	2/3 * V <sub>L</sub>	-	V
V <sub>ILL</sub>	I/O V <sub>L</sub> Input LOW Voltage		0.9 - 4.5	0.9 – 4.5	-	_	1/3 * VL	-	1/3 * V <sub>L</sub>	V
V <sub>IH</sub>	Control Pin Input HIGH Volt- age	T <sub>A</sub> = +25°C	0.9 - 4.5	0.9-4.5	2/3 * VL	_	-	2/3 * V <sub>L</sub>	-	V
V <sub>IL</sub>	Control Pin Input LOW Volt- age	T <sub>A</sub> = +25°C	0.9-4.5	0.9-4.5	-	_	1/3 * VL	-	1/3 * V <sub>L</sub>	V
V <sub>OHC</sub>	I/O V <sub>CC</sub> Output HIGH Volt- age	I/O V <sub>CC</sub> source current = 20 μA	0.9-4.5	0.9-4.5	0.9 * V <sub>CC</sub>	-		0.9* Vcc	_	V
V <sub>OLC</sub>	I/O V <sub>CC</sub> Output LOW Voltage	l/O V <sub>CC</sub> sink current = 20 μA	0.9-4.5	0.9-4.5	-		0.2	-	0.2	V
V <sub>OHL</sub>	I/O V <sub>L</sub> Output HIGH Voltage	I/O V <sub>L</sub> source current = 20 μA	0.9 – 4.5	0.9-4.5	0.9* V <sub>L</sub>	R	-	0.9 * V <sub>L</sub>	-	V
V <sub>OLL</sub>	I/O V <sub>L</sub> Output LOW Voltage	I/O V <sub>L</sub> sink current = 20 μA	0.9 - 4.5	0.9 – 4.5	0-	nsel	0.2	) -	0.2	V
I <sub>QVCC</sub>	V <sub>CC</sub> Supply Current		0.9 – 4.5	0.9-4.5	R	ORM	1	-	2.5	μA
I <sub>QVL</sub>	V <sub>L</sub> Supply Current	(I/O V <sub>CC</sub> = float, I/O V <sub>L</sub> = 0 V or V <sub>L</sub> )	0.9 – 4.5	0.9 – 4.5	<u> </u>	-	1	-	2.5	μA
I <sub>TS-VCC</sub>	V <sub>CC</sub> Tristate Output Mode Supply Current	$T_A = +25^{\circ}G,$ EN = 0 V $(I/O V_{CC} = 0 V or)$ $V_{CC}, I/O V_{L} = float)$	0.9+4.5	0.9-4.5	_	-	0.5	_	1.5	μA
I <sub>TS-VL</sub>	V <sub>L</sub> Tristate Output Mode Supply Current	$(I/O V_{CC} = float, I/O V_L = 0 V or V_L)$	0.9 – 4.5	0.9 – 4.5	-	_	0.5	-	1.5	μA
I <sub>OZ</sub>	I/O Tristate Output Mode Leakage Current	T <sub>A</sub> = +25°C, EN = 0V	0.9-4.5	0.9-4.5	-	-	±1	-	±1.5	μA
Ιį	Control Pin Input Current	T <sub>A</sub> = +25°C	0.9 - 4.5	0.9 – 4.5	-	_	±1	-	±1	μA
IOFF	Power Off Leakage Current	$I/O V_{CC} = 0 \text{ to } 4.5 \text{V},$	0	0	-	-	1	-	1.5	μA
		I/O V <sub>L</sub> = 0 to 4.5 V	0.9 - 4.5	0	-	-	1	-	1.5	
			0	0.9 - 4.5	-	-	1	-	1.5	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
Normal test conditions are V<sub>I</sub> = 0 V, C<sub>IOVCC</sub> ≤ 15 pF and C<sub>IOVL</sub> ≤ 15 pF, unless otherwise specified.
V<sub>CC</sub> is the supply voltage associated with the I/O V<sub>CC</sub> port, and V<sub>CC</sub> ranges from +0.9 V to 4.5 V under normal operating conditions.
V<sub>L</sub> is the supply voltage associated with the I/O V<sub>L</sub> port, and V<sub>L</sub> ranges from +0.9 V to 4.5 V under normal operating conditions.
Typical values are for V<sub>CC</sub> = +2.8 V, V<sub>L</sub> = +1.8 V and T<sub>A</sub> = +25°C. All units are production tested at T<sub>A</sub> = +25°C. Limits over the operating temperature range are guaranteed by design.

#### **TIMING CHARACTERISTICS**

					–55°C to +125°C			
Symbol	Parameter	Test Conditions (Note 5)	V <sub>CC</sub> (V) (Note 6)	<b>V<sub>L</sub> (V)</b> (Note 7)	Min	<b>Typ</b> (Note 8)	Мах	Unit
t <sub>R-VCC</sub>	I/O V <sub>CC</sub> Rise Time	C <sub>IOVCC</sub> = 15 pF	0.9-4.5	0.9-4.5	-	-	8.5	nS
			1.8 – 4.5	1.8 – 4.5	-	-	3.5	1
t <sub>F-VCC</sub>	I/O V <sub>CC</sub> Fall Time	C <sub>IOVCC</sub> = 15 pF	0.9 – 4.5	0.9 – 4.5	-	_	8.5	nS
			1.8 – 4.5	1.8 – 4.5	-	-	3.5	
t <sub>R-VL</sub>	I/O V <sub>L</sub> Rise Time	C <sub>IOVL</sub> = 15 pF	0.9 – 4.5	0.9 – 4.5	-	-	8.5	nS
			1.8 – 4.5	1.8 – 4.5	-	-	3.5	
$t_{F-VL}$	I/O V <sub>L</sub> Fall Time	C <sub>IOVL</sub> = 15 pF	0.9 – 4.5	0.9 – 4.5	-	-	8.5	nS
			1.8 – 4.5	1.8-4.5	1	_	3.5	1
Z <sub>OVCC</sub>	I/O V <sub>CC</sub> One-Shot Output Impedance	(Note 9)	0.9 1.8 4.5	0.9 – 4.5	-	37 20 6.0	13	Ω
Z <sub>OVL</sub>	I/O V <sub>L</sub> One-Shot Out- put Impedance	(Note 9)	0.9 1.8 4.5	0.9-4.5	-	37 20 6.0		Ω
PD_VL-VCC	Propagation Delay	C <sub>IOVCC</sub> = 15 pF	0.9 - 4.5	0.9 – 4.5	<u> </u>	-	35	nS
	(Driving I/O V <sub>CC</sub> )		1.8 – 4.5	1.8 - 4.5	-	_	10	1
		C <sub>IOVCC</sub> = 30 pF	0.9 – 4.5	0.9 – 4.5	<u> </u>	11	35	1
			1.8 - 4.5	1.8 - 4.5	St,	-	10	
		C <sub>IOVCC</sub> = 50 pF	1.0-4.5	1.0-4.5	,	-	37	
			1.8-4.5	1.8-4.5	-	-	11	
		C <sub>IOVCC</sub> = 100 pF	1.2 - 4.5	1.2 - 4.5	-	-	40	1
		FUSA	1.8 - 4.5	1.8 – 4.5	-	-	13	1
PD_VCC-VL	Propagation Delay	C <sub>IOVL</sub> = 15 pF	0.9 - 4.5	0.9-4.5	-	-	35	nS
	(Driving I/O V <sub>L</sub> )		1.8 – 4.5	1.8-4.5	-	-	10	]
		C <sub>IOVL</sub> = 30 pF	0.9 - 4.5	0.9 – 4.5	-	-	35	
	C.F.	FALN	1.8 – 4.5	1.8 - 4.5	-	-	10	1
	DEVICE	C <sub>IOVL</sub> = 50 pF	1.0 - 4.5	1.0-4.5	I	-	37	1
	C DE	PKL	1.8 – 4.5	1.8-4.5	-	-	11	
~	JIS F	C <sub>IOVL</sub> = 100 pF	1.2 – 4.5	1.2 – 4.5	-	-	40	1
1			1.8 – 4.5	1.8 - 4.5	-	-	13	1
t <sub>SK</sub>	Channel-to-Channel Skew	C <sub>IOVCC</sub> = 15 pF, C <sub>IOVL</sub> = 15 pF (Note 9)	0.9 – 4.5	0.9 – 4.5	I	-	0.15	nS
I <sub>IN_PEAK</sub>	Input Driver Maximum Peak Current	$\begin{array}{l} EN = V_L;\\ I/O\_V_{CC} = 1 \ MHz \ Square \ Wave,\\ Amplitude = V_{CC}, \ or\\ I/O\_V_L = 1 \ MHz \ Square \ Wave,\\ Amplitude = V_L \ (Note 9) \end{array}$	0.9 – 4.5	0.9 – 4.5	_	_	5.0	mA

Normal test conditions are V<sub>I</sub> = 0 V, C<sub>IOVCC</sub> ≤ 15 pF and C<sub>IOVL</sub> ≤ 15 pF, unless otherwise specified.
 V<sub>CC</sub> is the supply voltage associated with the I/O V<sub>CC</sub> port, and V<sub>CC</sub> ranges from +0.9 V to 4.5 V under normal operating conditions.
 V<sub>L</sub> is the supply voltage associated with the I/O V<sub>L</sub> port, and V<sub>L</sub> ranges from +0.9 V to 4.5 V under normal operating conditions.
 Typical values are for V<sub>CC</sub> = +2.8 V, V<sub>L</sub> = +1.8 V and T<sub>A</sub> = +25°C. All units are production tested at T<sub>A</sub> = +25°C. Limits over the operating temperature range are guaranteed by design.
 Ourserverse the values are to values.

9. Guaranteed by design.

#### **TIMING CHARACTERISTICS (continued)**

						-5	5°C to +125	5°C	
Symbol	Parameter		Test Conditions (Note 10)	V <sub>CC</sub> (V) (Note 11)	<b>V<sub>L</sub> (V)</b> (Note 12)	Min	<b>Typ</b> (Note 13)	Max	Unit
t <sub>EN-VCC</sub>	I/O_V <sub>CC</sub> Output Enable Time	t <sub>PZH</sub>	$C_{IOVCC} = 15 \text{ pF},$ I/O_V <sub>L</sub> = V <sub>L</sub>	0.9-4.5	0.9 – 4.5	-	-	160	nS
		t <sub>PZL</sub>	C <sub>IOVCC</sub> = 15 pF, I/O_V <sub>L</sub> = 0 V	0.9-4.5	0.9 – 4.5	-	-	130	
t <sub>EN-VL</sub>	I/O_V <sub>L</sub> Output Enable Time	t <sub>PZH</sub>	$C_{IOVL} = 15 \text{ pF},$ I/O_V <sub>CC</sub> = V <sub>CC</sub>	0.9-4.5	0.9 – 4.5	-	-	160	nS
		t <sub>PZL</sub>	C <sub>IOVL</sub> = 15 pF, I/O_V <sub>CC</sub> = 0 V	0.9-4.5	0.9 – 4.5	-	-	130	
t <sub>DIS-VCC</sub>	I/O_V <sub>CC</sub> Output Disable Time	t <sub>PHZ</sub>	$C_{IOVCC} = 15 \text{ pF},$ I/O_V <sub>L</sub> = V <sub>L</sub>	0.9-4.5	0.9 – 4.5	-	-	210	nS
		t <sub>PLZ</sub>	$C_{IOVCC} = 15 \text{ pF},$ I/O_V <sub>L</sub> = 0 V	0.9-4.5	0.9 – 4.5	-	-	175	
t <sub>DIS-VL</sub>	I/O_V <sub>L</sub> Output Disable Time	t <sub>PHZ</sub>	C <sub>IOVL</sub> = 15 pF, I/O_V <sub>CC</sub> = V <sub>CC</sub>	0.9-4.5	0.9 – 4.5	5	251	210	nS
		t <sub>PLZ</sub>	C <sub>IOVL</sub> = 15 pF, I/O_V <sub>CC</sub> = 0 V	0.9-4.5	0.9 - 4.5	2	QE	175	
MDR	Maximum Data Rate		C <sub>IO</sub> = 15 pF	0.9 – 4.5	0.9-4.5	50	-	-	mbps
				1.8-4.5	1.8 - 4.5	140	_	-	
			C <sub>IO</sub> = 30 pF	0.9 – 4.5	0.9 – 4.5	40	1	-	
				1.8-4.5	1.8-4.5	120	- 1	-	
			C <sub>IO</sub> = 50 pF	1.0 - 4.5	1.0-4.5	30	-	-	
				1.8 – 4.5	1.8 - 4.5	100	-	-	
			C <sub>IO</sub> = 100 pF	1.2-4.5	1.2 – 4.5	20	-	-	
				1.8 – 4.5	1.8 – 4.5	60	_	-	

 1.8 - 4.5
 60

 10. Normal test conditions are V<sub>1</sub> = 0 V, C<sub>IOVCC</sub> ≤ 15 pF and C<sub>IOVL</sub> ≤ 15 pF, unless otherwise specified.

 11. V<sub>CC</sub> is the supply voltage associated with the I/O V<sub>CC</sub> port, and V<sub>CC</sub> ranges from +0.9 V to 4.5 V under normal operating conditions.

 12. V<sub>L</sub> is the supply voltage associated with the I/O V<sub>L</sub> port, and V<sub>L</sub> ranges from +0.9 V to 4.5 V under normal operating conditions.

 13. Typical values are for V<sub>CC</sub> = +2.8 V, V<sub>L</sub> = +1.8 V and T<sub>A</sub> = +25°C. All units are production tested at T<sub>A</sub> = +25°C. Limits over the operating temperature range are guaranteed by design.

Symbol	Parameter	Test Conditions	V <sub>CC</sub> (V) (Note 14)	<b>V<sub>L</sub> (V)</b> (Note 15)	<b>Typ</b> (Note 16)	Unit
$C_{PD_VL}$	$V_L = Input port,$	$C_{Load} = 0, f = 1 MHz,$	0.9	4.5	39	pF
	V <sub>CC</sub> = Output Port	$EN = V_L$ (outputs enabled)	1.5	1.8	20	
			1.8	1.5	17	
			1.8	1.8	14	
			1.8	2.8	13	
			2.5	2.5	14	
			2.8	1.8	13	
			4.5	0.9	19	
	$V_{CC} = $ Input port,	$C_{\text{Load}} = 0, f = 1 \text{ MHz},$	0.9	4.5	37	pF
	V <sub>L</sub> = Output Port	$EN = V_L$ (outputs enabled)	1.5	1.8	30	
			1.8	1.5	29	
			1.8	1.8	29	
			1.8	2.8	29	
			2.5	2.5	30	
			2.8	1.8	29	
			4.5	0.9	19	
C <sub>PD_VCC</sub>	$V_{L} = $ Input port,	$V_L = Input port,$ $C_{Load} = 0, f = 1 MHz,$	0.9	<b>6</b> 4.5	29	pF
	$V_{CC} = Output Port$	$EN = V_L$ (outputs enabled)	1.5	1.8	29	
		I I I I I I I I I I I I I I I I I I I	1.8	1.5	29	
		- MAN-	1.8	1.8	29	
			1.8	2.8	29	
		RETACE	2.5	2.5	30	
		$C_{Load} = 0, f = 1.MHz, EN = V_L (outputs enabled)$	2.8	1.8	29	
		NOFOTIN	4.5	0.9	35	
	$V_{CC}$ = Input port,	$C_{Load} = 0, f = 1 MHz,$	0.9	4.5	21	pF
	V <sub>L</sub> = Output Port	$\overline{EN} = V_{L}$ (outputs enabled)	1.5	1.8	18	
	SEV.	r RE	1.8	1.5	18	
	HISDE	EPI	1.8	1.8	14	
~	HIL	K	1.8	2.8	13	
	h		2.5	2.5	14	
			2.8	1.8	13	
			4.5	0.9	30	

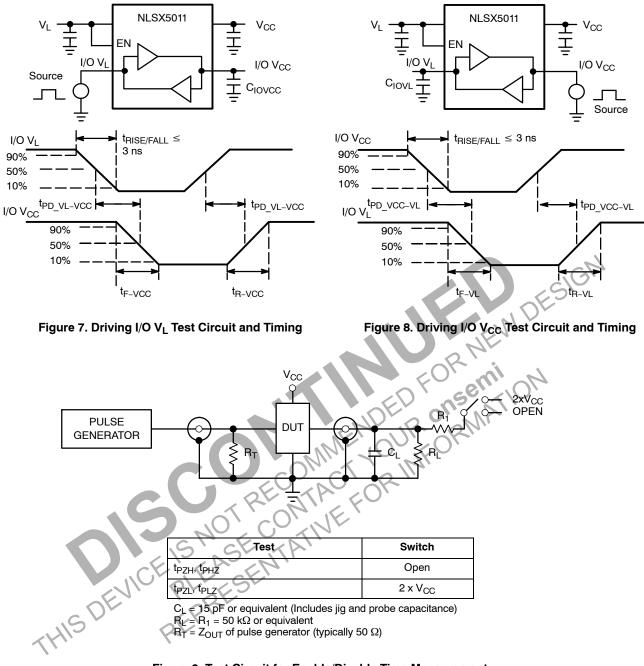
#### DYNAMIC POWER CONSUMPTION (T<sub>A</sub> = +25°C)

14.  $V_{CC}$  is the supply voltage associated with the I/O Vcc port, and Vcc ranges from +0.9 V to 4.5 V under normal operating conditions. 15.  $V_L$  is the supply voltage associated with the I/O VL port, and VL ranges from +0.9 V to 4.5 V under normal operating conditions. 16. Typical values are at  $T_A = +25^{\circ}$ C. 17.  $C_{PD \ VL}$  and  $C_{PD \ VCC}$  are defined as the value of the IC's equivalent capacitance from which the operating current can be calculated for the  $V_L$  and  $V_{CC}$  power supplies, respectively.  $I_{CC} = I_{CC}$  (dynamic) +  $I_{CC}$  (static)  $\approx I_{CC}$ (operating)  $\approx C_{PD} \times V_{CC} \times f_{IN} \times N_{SW}$  where  $I_{CC} = I_{CC} \ V_{CC} \times f_{IN} \times N_{SW}$  where  $I_{CC} = I_{CC} \ V_{CC} \times f_{IN}$  and  $N_{SW}$  = total number of outputs switching.

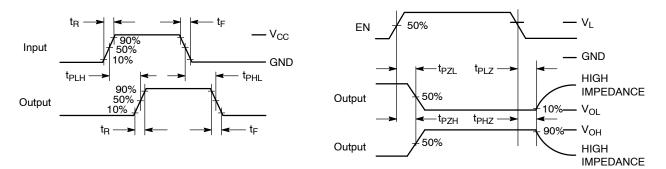
Symbol	Parameter	Test Conditions	V <sub>CC</sub> (V) (Note 18)	<b>V<sub>L</sub> (V)</b> (Note 19)	<b>Typ</b> (Note 20)	Unit
$C_{PD_VL}$	$V_L = Input port,$	$V_L$ = Input port, $V_{CC}$ = Output Port $EN = GND$ (outputs disabled)	0.9	4.5	0.01	pF
	V <sub>CC</sub> = Output Port		1.5	1.8	0.01	
			1.8	1.5	0.01	
			1.8	1.8	0.01	
			1.8	2.8	0.01	
			2.5	2.5	0.01	
			2.8	1.8	0.01	
			4.5	0.9	0.01	
	$V_{CC}$ = Input port, $V_{L}$ = Output Port	C <sub>Load</sub> = 0, f = 1 MHz, EN = GND (outputs disabled)	0.9	4.5	0.01	pF
	$v_{L} = Output Port [EN = GND (outputs disabled)$	1.5	1.8	0.01		
			1.8	1.5	0.01	
			1.8	1.8	0,01	
			1.8	2.8	0.01	
			2.5	2.5	0.01	
			2.8	2 1.8	0.01	
			4.5	0.9	0.01	
C <sub>PD_VCC</sub>	V <sub>L</sub> = Input port, V <sub>CC</sub> = Output Port	C <sub>Load</sub> = 0, f = 1 MHz, EN = GND (outputs disabled)	0.9	<b>6</b> 4.5	0.01	pF
	V <sub>CC</sub> = Output Port	EN = GND (outputs disabled)	1.5	1.8	0.01	
		NER STREET	1.8	1.5	0.01	
		- NNVI-	1.8	1.8	0.01	
		CON CI	1.8	2.8	0.01	
		RESTACE	2.5	2.5	0.01	
		OT'CONNE'	2.8	1.8	0.01	
		CNOF	4.5	0.9	0.01	
	$V_{CC}$ = Input port, $V_{L}$ = Output Port	C <sub>Load</sub> = 0, f = 1 MHz, EN = GND (outputs disabled)	0.9	4.5	0.01	pF
	$V_{L} = Output Port$	EN = GND (outputs disabled)	1.5	1.8	0.01	
	DEV.	T RE	1.8	1.5	0.01	
	HISDEVI	it port, t Port EN = GND (outputs disabled)	1.8	1.8	0.01	
<	HI-	K	1.8	2.8	0.01	
			2.5	2.5	0.01	
			2.8	1.8	0.01	
			4.5	0.9	0.01	

#### **STATIC POWER CONSUMPTION** (T<sub>A</sub> = +25°C)

18. V<sub>CC</sub> is the supply voltage associated with the I/O V<sub>CC</sub> port, and V<sub>CC</sub> ranges from +0.9 V to 4.5 V under normal operating conditions. 19. V<sub>L</sub> is the supply voltage associated with the I/O V<sub>L</sub> port, and V<sub>L</sub> ranges from +0.9 V to 4.5 V under normal operating conditions. 20. Typical values are at T<sub>A</sub> = +25°C









#### IMPORTANT APPLICATIONS INFORMATION

#### Level Translator Architecture

The NLSX5011 auto-sense translator provides bi-directional logic voltage level shifting to transfer data in multiple supply voltage systems. These level translators have two supply voltages,  $V_L$  and  $V_{CC}$ , which set the logic levels on the input and output sides of the translator. When used to transfer data from the I/O  $V_L$  to the I/O  $V_{CC}$  ports, input signals referenced to the  $V_L$  supply are translated to output signals with a logic level matched to  $V_{CC}$ . In a similar manner, the I/O  $V_{CC}$  to I/O  $V_L$  translation shifts input signals with a logic level compatible to  $V_{CC}$  to an output signal matched to  $V_L$ .

The NLSX5011 translator consists of bi-directional channels that independently determine the direction of the data flow without requiring a directional pin. One-shot circuits are used to detect the rising or falling input signals. In addition, the one-shots decrease the rise and fall times of the output signal for high-to-low and low-to-high transitions.

#### **Input Driver Requirements**

Auto-sense translators such as the NLSX5011 have a wide bandwidth, but a relatively small DC output current rating. The high bandwidth of the bi-directional I/O circuit is used to quickly transform from an input to an output driver and vice versa. The I/O ports have a modest DC current output specification so that the output driver can be over driven when data is sent in the opposite direction. For proper operation, the input driver to the auto-sense translator should be capable of driving 2 mA of peak output current. The bi-directional configuration of the translator results in both input stages being active for a very short time period. Although the peak current from the input signal circuit is relatively large, the average current is small and consistent with a standard CMOS input stage.

#### Enable Input (EN)

The NLSX5011 translator has an Enable pin (EN) that provides tri-state operation at the I/O pins. Driving the Enable pin to a low logic level minimizes the power consumption of the device and drives the I/O  $V_{CC}$  and I/O

 $V_L$  pins to a high impedance state. Normal translation operation occurs when the EN pin is equal to a logic high signal. The EN pin is referenced to the  $V_L$  supply and has Over–Voltage Tolerant (OVT) protection.

#### Uni-Directional versus Bi-Directional Translation

The NLSX5011 translator can function as a non-inverting uni-directional translator. One advantage of using the translator as a uni-directional device is that each I/O pin can be configured as either an input or output. The configurable input or output feature is especially useful in applications such as SPI that use multiple uni-directional I/O lines to send data to and from a device. The flexible I/O port of the auto sense translator simplifies the trace connections on the PCB.

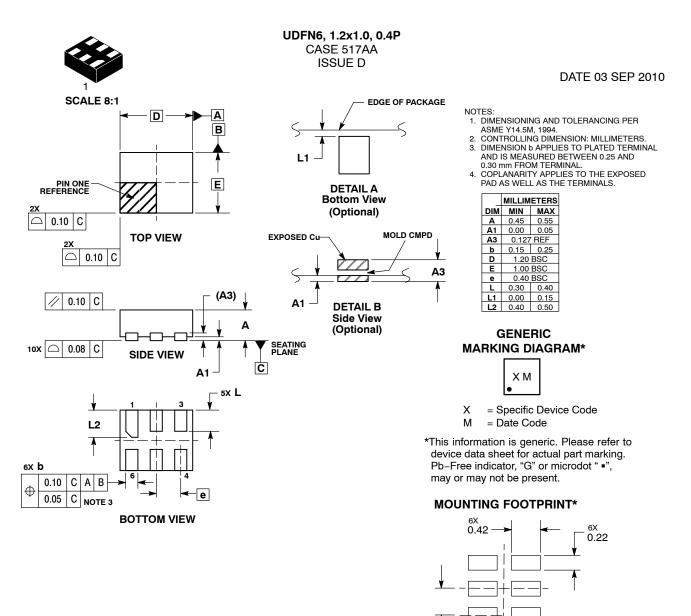
#### **Power Supply Guidelines**

The values of the  $V_L$  and  $V_{CC}$  supplies can be set to anywhere between 0.9 and 4.5 V. Design flexibility is maximized because  $V_L$  may be either greater than or less than the  $V_{CC}$  supply. In contrast, the majority of the competitive auto sense translators has a restriction that the value of the  $V_L$  supply must be equal to less than ( $V_{CC}$  – 0.4) V.

The sequencing of the power supplies will not damage the device during power-up operation. In addition, the I/O  $V_{CC}$  and I/O  $V_L$  pins are in the high impedance state if either supply voltage is equal to 0 V. For optimal performance, 0.01 to 0.1  $\mu$ F decoupling capacitors should be used on the  $V_L$  and  $V_{CC}$  power supply pins. Ceramic capacitors are a good design choice to filter and bypass any noise signals on the voltage lines to the ground plane of the PCB. The noise immunity will be maximized by placing the capacitors as close as possible to the supply and ground pins, along with minimizing the PCB connection traces.

The NLSX5011 translators have a power down feature that provides design flexibility. The output ports are disabled when either power supply is off ( $V_L$  or  $V_{CC} = 0$  V). This feature causes all of the I/O pins to be in the power saving high impedance state.

## semi



1.07 PITCH DIMENSIONS: MILLIMETERS

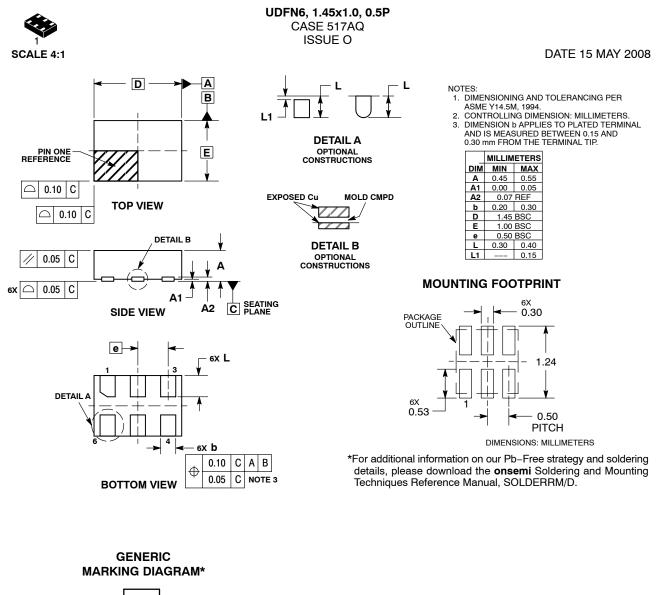
\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

0.40

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